

# Voltage comparator

# NE527

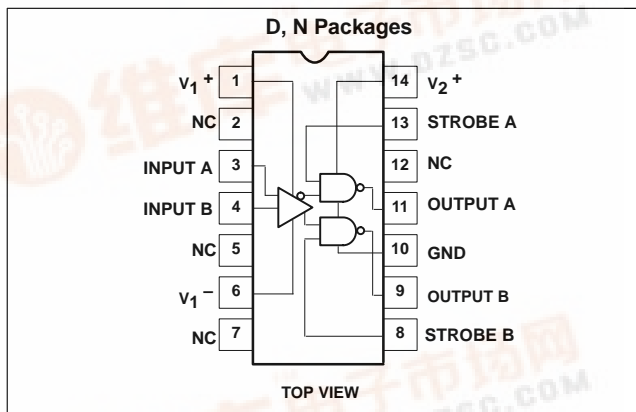
## DESCRIPTION

The NE527 is a high-speed analog voltage comparator which, for the first time, mates state-of-the-art Schottky diode technology with the conventional linear process. This allows simultaneous fabrication of high speed TTL gates with a precision linear amplifier on a single monolithic chip. The NE527 is similar in design to the Philips Semiconductors NE529 voltage comparator except that it incorporates an "Emitter-Follower" input stage for extremely low input currents. This opens the door to a whole new range of applications for analog voltage comparators.

## FEATURES

- 15ns propagation delay
- Complementary output gates
- TTL or ECL compatible outputs
- Wide common-mode and differential voltage range
- Typical gain of 5000

## PIN CONFIGURATIONS



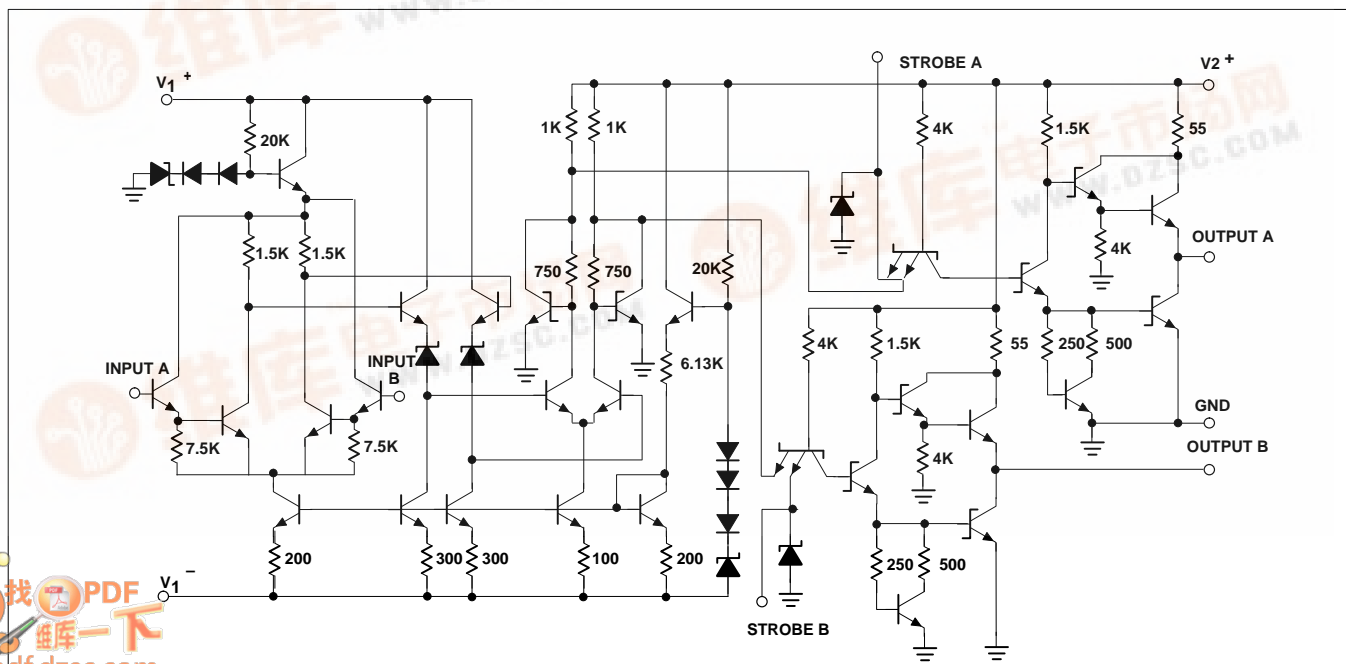
## APPLICATIONS

- A/D conversion
- ECL-to-TTL interface
- TTL-to-ECL interface
- Memory sensing
- Optical data coupling

## ORDERING INFORMATION

DESCRIPTION	TEMPERATURE RANGE	ORDER CODE	DWG #
14-Pin Plastic Dual In-Line Package (DIP)	0 to +70°C	NE527N	0405B
14-Pin Small Outline (SO) Package	0 to +70°C	NE527D	0175D

## EQUIVALENT SCHEMATIC



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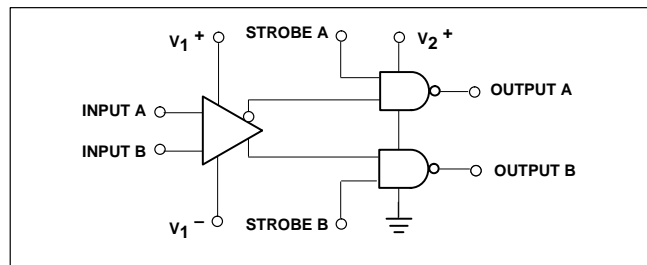
## ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNIT
V <sub>1+</sub>	Positive supply voltage	+15	V
V <sub>1-</sub>	Negative supply voltage	-15	V
V <sub>2+</sub>	Gate supply voltage	+7	V
V <sub>OUT</sub>	Output voltage	+7	V
V <sub>IN</sub>	Differential input voltage	±5	V
V <sub>CM</sub>	Input common mode voltage	±6	V
P <sub>D</sub>	Max power dissipation <sup>1</sup> 25°C ambient (still air)		
	N package	1420	mW
	D package	1040	mW
T <sub>A</sub>	Operating temperature range	0 to +70	°C
T <sub>STG</sub>	Storage temperature range	-65 to +150	°C
T <sub>SOLD</sub>	Lead soldering temperature (10sec max)	+300	°C

### NOTES:

- Derate above 25°C, at the following rates:  
 N package 11.4mW/°C  
 D package 8.3mW/°C

## BLOCK DIAGRAM



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**DC ELECTRICAL CHARACTERISTICS**V<sub>1+</sub>=10V, V<sub>1-</sub>=-10V, V<sub>2+</sub>=+5.0V, unless otherwise specified.

SYMBOL	PARAMETER	TEST CONDITIONS	NE527			UNIT
			Min	Typ	Max	
<b>Input characteristics</b>						
V <sub>OS</sub>	Input offset voltage @ 25°C over temperature range				6 10	mV
I <sub>BIAS</sub>	Input bias current @ 25°C over temperature range				2 4	μA
I <sub>OS</sub>	Input offset current @ 25°C over temperature range	V <sub>IN</sub> =0V			0.75 1	μA
V <sub>CM</sub>	Common-mode voltage range		-5		+5	V
<b>Gate characteristics</b>						
V <sub>OUT</sub>	Output Voltage					
	"1" State	V <sub>2+</sub> =4.75V, I <sub>SOURCE</sub> =-1mA	2.7	3.3		V
	"0" State	V <sub>2+</sub> =4.75V, I <sub>SINK</sub> =10mA			0.5	V
	Strobe inputs					
	"0" Input current <sup>1</sup>	V <sub>2+</sub> =5.25V, V <sub>STROBE</sub> =0.5V			-2	mA
	"1" Input current @ 25°C <sup>1</sup>	V <sub>2+</sub> =5.25V, V <sub>STROBE</sub> =2.7V			100	μA
	Over temperature range	V <sub>2+</sub> =5.25V, V <sub>STROBE</sub> =2.7V			200	μA
	"0" Input voltage	V <sub>2+</sub> =4.75V			0.8	V
	"1" Input voltage	V <sub>2+</sub> =4.75V	2.0			V
I <sub>SC</sub>	Short-circuit output current	V <sub>2+</sub> =5.25V, V <sub>OUT</sub> =0V	-18		-70	mA
<b>Power supply requirements</b>						
V <sub>1+</sub>	Supply voltage		5		10	V
V <sub>1-</sub>			-6		-10	V
V <sub>2+</sub>			4.75	5	5.25	V
I <sub>1+</sub>	Supply current	V <sub>1+</sub> =10V, V <sub>1-</sub> =-10V V <sub>2+</sub> =5.25V Over temp.			5	mA
I <sub>1-</sub>					10	mA
I <sub>2+</sub>					20	mA

**NOTES:**

1. See Logic Function Table.

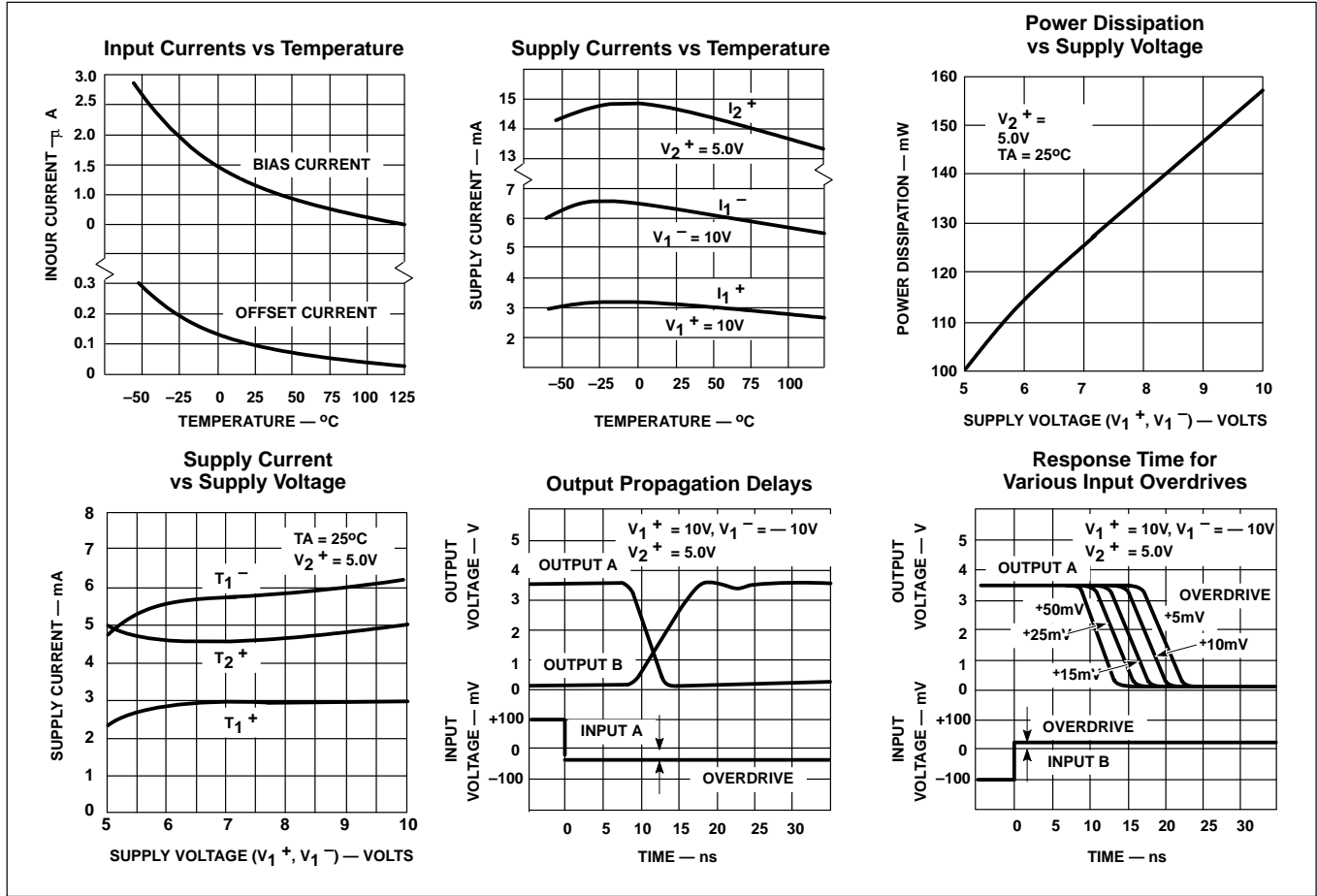
**AC ELECTRICAL CHARACTERISTICS**T<sub>A</sub>=25°C, unless otherwise specified. (See AC test circuit)

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			Min	Typ	Max	
t <sub>PLH</sub>	Transient response propagation delay time Low-to-High	V <sub>IN</sub> =±100mV step		16	26	ns
t <sub>PHL</sub>	High-to-Low			14	24	ns
	Delay between output A and B			2	5	ns
t <sub>ON</sub>	Strobe delay time Turn-on time			6		ns
t <sub>OFF</sub>	Turn-off time			6		ns

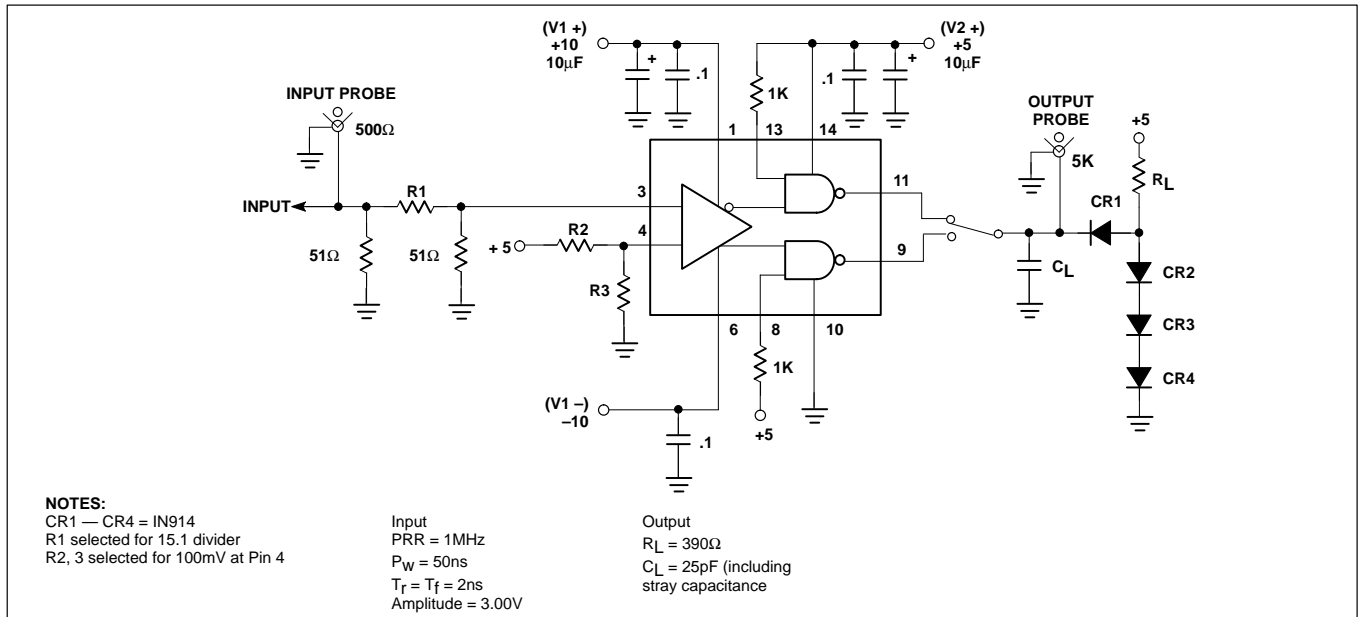
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## TYPICAL PERFORMANCE CHARACTERISTICS



## RESPONSE TIME TEST CIRCUIT



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## APPLICATIONS

One of the main features of the device is that supply voltages ( $V_{1+}$ ,  $V_{1-}$ ) need not be balanced, as in the following diagrams. For proper operation, however, negative supply ( $V_{1-}$ ) should always be at least 6V more than the ground terminal (Pin 6). Input common-mode range should be limited to values of 2V less than the supply voltages ( $V_{1+}$  and  $V_{1-}$ ) up to a maximum of  $\pm 5V$  as supply voltages are increased. It is also important to note that Output A is in phase with Input A and Output B is in phase with Input B.

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## LOGIC FUNCTION

$V_{ID}$ (A+, B-)	STROBE A	STROBE B	OUTPUT A	OUTPUT B	COMMENT
$V_{ID} \leq -V_{OS}$	H	X	L	H	Read $I_{IHA}$ , $I_{ILB}$
$-V_{OS} < V_{ID} < V_{OS}$	H	H	Undefined	Undefined	
$V_{ID} \geq V_{OS}$	X	H	H	L	Read $I_{ILA}$ , $I_{IHB}$
X	L	L	H	H	

## TYPICAL APPLICATIONS

